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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Application Serial No. 09/653,149
Confirmation No. 4634
Filing Date August 31, 2000
Inventor Garo J. Derderian, et al.
Assignee Micron Technology, Inc.
Group Art Unit 2818
Examiner T. Lee
Attorney's Docket No. MI22-1330
Customer No. 021567
Title: Capacitor Fabrication Methods Including Forming a Conductive Layer

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

To: Commissioner for Patents
PO Box 1450
Art Unit 2818
Alexandria, VA 22313-1450

RECEIVED

OCT 18 2004

TECH CENTER 2800

From: James E. Lake (Tel. 509-624-4276; Fax 509-838-3424)
Wells St. John P.S.
601 W. First Avenue, Suite 1300
Spokane, WA 99201-3828

References - See attached Form PTO-1449

In compliance with 37 C.F.R. §§ 1.56, 1.97 and 1.98, your attention is directed to the United States patents and other references listed on the attached Form PTO-1449. No admission is made regarding whether all the submitted references are prior art.

Citation of these references is respectfully requested.

10/14/2004 BSAYASII 00000093 09653149

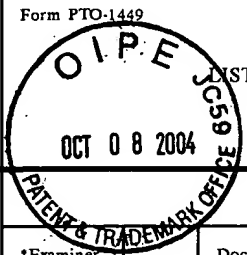
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Respectfully submitted,

Dated: 08 Oct 2004

By: James E. Lake
James E. Lake
Reg. No. 44,854

Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. MI22-1330		SERIAL NO. 09/653,149	
 LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT Garo J. Derderian			
				FILING DATE August 31, 2000		GROUP 2818	
U.S. PATENT DOCUMENTS							
*Examiner Initial	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate	
AA	5,452,178	09/95	Emesh et al				
AB	6,458,416	10/02	Derderian et al				
AC	6,309,923	10/01	Tseng, Horng-Huei				
AD	6,548,424	05/03	Putkonen				
AE	6,632,279	10/03	Ritala				
AF	6,270,572	08/01	Kim et al				
AG	6,780,704	4/03	Sneh et al				
AH	6,551,399	08/04	Raaijmakers et al				
AI							
AJ							
AK							
FOREIGN PATENT DOCUMENTS							
	Document Number	Date	Country	Class	Subclass	Translation	
						Yes	No
AL							
AM							
AN							
OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)							
AO							
AP							
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EXAMINER				DATE CONSIDERED			
*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							